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_	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/918,825	BERK ET AL.
	Examiner	Art Unit
	Tri V Nauven	3622

SEARCHED				
Class	Subclass	Date	Examiner	
705	14	10/26/2005	NVT	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
east (us-pgpubs; uspat; jpo; epo; derwent; ibm_tdb). See attached sheet.	10/28/2005	NVT	